S	Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,437	CHANG ET AL.	
Examiner	Art Unit	
Brian S. Kwon	1614	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated	see search notes	8/14/2007	вк	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
514	255.04	8/14/2007	вк		
	266.04				
	253.01				
	<u> </u>				

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Updated (STN, EAST, NPL)	8/14/2007	вк
Updated (Continuity Data, Inventor Name Search)		
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